



# AS6C1608B

16Mb (2048K x 8 Bits) LOW POWER CMOS SRAM

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## REVISION HISTORY

<u>Revision</u>	<u>Description</u>	<u>Issue Date</u>
Rev. 1.0	Initial release	Feb.25.2022

### FEATURES

- Fast access time : 45ns
- Low power consumption:  
Operating current : 12mA (TYP.)  
Standby current : 5μA (TYP.)
- Single 2.7V ~ 3.6V power supply
- All inputs and outputs TTL compatible
- Fully static operation
- Tri-state output
- Data retention voltage : 1.5V (MIN.)
- Package : 44-pin 400 mil TSOP-II  
48-ball 6mm x 8mm TFBGA

### GENERAL DESCRIPTION

The AS6C1608B is a 16,777,216-bit low power CMOS static random access memory organized as 2,097,152 words by 8 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

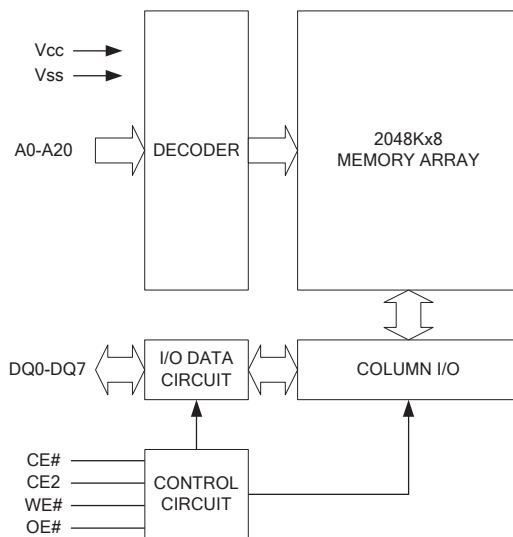
The AS6C1608B is well designed for very low power system applications, and particularly well suited for battery back-up nonvolatile memory application.

The AS6C1608B operates from a single power supply of 2.7V ~ 3.6V and all inputs and outputs are fully TTL compatible

### PRODUCT FAMILY

Product Family	Operating Temperature	Vcc Range	Speed	Power Dissipation	
				Standby(I <sub>SB1</sub> , TYP.)	Operating(I <sub>CC</sub> , TYP.)
AS6C1608B(I)	-40 ~ 85°C	2.7 ~ 3.6V	45ns	5μA	12mA

### FUNCTIONAL BLOCK DIAGRAM

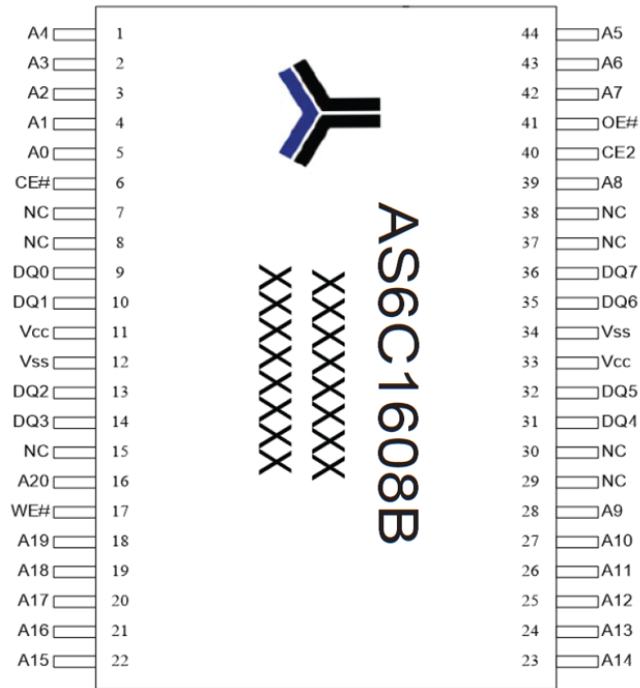


### PIN DESCRIPTION

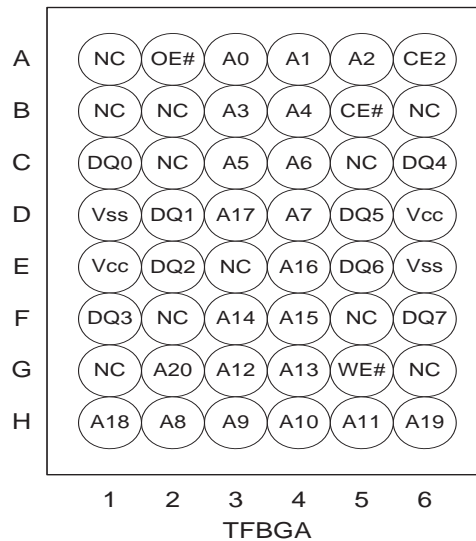
SYMBOL	DESCRIPTION
A0 – A20	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
CE#, CE2	Chip Enable Inputs
WE#	Write Enable Input
OE#	Output Enable Input
Vcc	Power Supply
Vss	Ground
NC	No Connection

### PIN CONFIGURATION

44-pin TSOP(Type II)



48-ball 6mm x 8mm TFBGA



### ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	RATING	UNIT
Voltage on V <sub>CC</sub> relative to V <sub>SS</sub>	V <sub>T1</sub>	-0.5 to 4.6	V
Voltage on any other pin relative to V <sub>SS</sub>	V <sub>T2</sub>	-0.5 to V <sub>CC</sub> +0.5	V
Operating Temperature	T <sub>A</sub>	-40 to 85(l grade)	°C
Storage Temperature	T <sub>STG</sub>	-65 to 150	°C
Power Dissipation	P <sub>D</sub>	1	W
DC Output Current	I <sub>OUT</sub>	50	mA

\*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

### TRUTH TABLE

MODE	CE#	CE2	OE#	WE#	I/O OPERATION	SUPPLY CURRENT
Standby	H	X	X	X	High-Z	I <sub>SB</sub> , I <sub>SB1</sub>
	X	L	X	X	High-Z	I <sub>SB</sub> , I <sub>SB1</sub>
Output Disable	L	H	H	H	High-Z	I <sub>CC</sub> , I <sub>CC1</sub>
Read	L	H	L	H	D <sub>OUT</sub>	I <sub>CC</sub> , I <sub>CC1</sub>
Write	L	H	X	L	D <sub>IN</sub>	I <sub>CC</sub> , I <sub>CC1</sub>

Note: H = V<sub>IH</sub>, L = V<sub>IL</sub>, X = Don't care.

### DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP. <sup>4</sup>	MAX.	UNIT
Supply Voltage	V <sub>CC</sub>			2.7	3.0	3.6	V
Input High Voltage	V <sub>IH</sub> <sup>1</sup>			2.2	-	V <sub>CC</sub> +0.3	V
Input Low Voltage	V <sub>IL</sub> <sup>2</sup>			- 0.2	-	0.6	V
Input Leakage Current	I <sub>LI</sub>	V <sub>CC</sub> ≥ V <sub>IN</sub> ≥ V <sub>SS</sub>		- 1	-	1	μA
Output Leakage Current	I <sub>LO</sub>	V <sub>CC</sub> ≥ V <sub>OUT</sub> ≥ V <sub>SS</sub> Output Disabled		- 1	-	1	μA
Output High Voltage	V <sub>OH</sub>	I <sub>OH</sub> = -1mA		2.2	2.7	-	V
Output Low Voltage	V <sub>OL</sub>	I <sub>OL</sub> = 2mA		-	-	0.4	V
Average Operating Power supply Current	I <sub>CC</sub>	Cycle time = Min. CE# = V <sub>IL</sub> and CE2 = V <sub>IH</sub> I <sub>I/O</sub> = 0mA Other pins at V <sub>IL</sub> or V <sub>IH</sub>	- 45	-	12	20	mA
			- 55	-	10	18	mA
	I <sub>CC1</sub>	Cycle time = 1μs CE# ≤ 0.2V and CE2 ≥ V <sub>CC</sub> -0.2V I <sub>I/O</sub> = 0mA Other pins at 0.2V or V <sub>CC</sub> -0.2V		-	3	5	mA
Standby Power Supply Current	I <sub>SB</sub>	CE# = V <sub>IH</sub> or CE2 = V <sub>IL</sub> Other pins at V <sub>IL</sub> or V <sub>IH</sub>		-	0.3	2	mA
	I <sub>SB1</sub>	CE# ≥ V <sub>CC</sub> -0.2V or CE2 ≤ 0.2V Other pins at 0.2V or V <sub>CC</sub> -0.2V	25°C <sup>5</sup>	-	5	10	μA
				-	5	20	μA

Notes:

- V<sub>IH</sub>(max) = V<sub>CC</sub> + 2.0V for pulse width less than 6ns.
- V<sub>IL</sub>(min) = V<sub>SS</sub> - 2.0V for pulse width less than 6ns.
- Over/Undershoot specifications are characterized on engineering evaluation stage, not for mass production test.
- Typical values are included for reference only and are not guaranteed or tested.
- Typical values are measured at V<sub>CC</sub> = V<sub>CC</sub>(TYP.) and T<sub>A</sub> = 25°C
- This parameter is measured at V<sub>CC</sub> = 3.0V

### CAPACITANCE (T<sub>A</sub> = 25°C pF = 1.0MHz)

PARAMETER	SYMBOL	MIN.	MAX	UNIT
Input Capacitance	C <sub>IN</sub>	-	6	pF
Input/Output Capacitance	C <sub>I/O</sub>	-	8	pF

Note : These parameters are guaranteed by device characterization, but not production tested.

### AC TEST CONDITIONS

Input Pulse Levels	0.2V to V <sub>CC</sub> - 0.2V
Input Rise and Fall Times	3ns
Input and Output Timing Reference Levels	1.5V
Output Load	C <sub>L</sub> = 30pF + 1TTL, I <sub>OH</sub> /I <sub>OL</sub> = -1mA/2mA

### AC ELECTRICAL CHARACTERISTICS

#### (1) READ CYCLE

PARAMETER	SYM.	AS6C1608B-45		55ns Specification		UNIT
		MIN.	MAX.	MIN.	MAX.	
Read Cycle Time	t <sub>RC</sub>	45	-	55	-	ns
Address Access Time	t <sub>AA</sub>	-	45	-	55	ns
Chip Enable Access Time	t <sub>ACE</sub>	-	45	-	55	ns
Output Enable Access Time	t <sub>OE</sub>	-	25	-	30	ns
Chip Enable to Output in Low-Z	t <sub>CLZ</sub> *	10	-	10	-	ns
Output Enable to Output in Low-Z	t <sub>OLZ</sub> *	5	-	5	-	ns
Chip Disable to Output in High-Z	t <sub>CHZ</sub> *	-	15	-	20	ns
Output Disable to Output in High-Z	t <sub>OHZ</sub> *	-	15	-	20	ns
Output Hold from Address Change	t <sub>OH</sub>	10	-	10	-	ns

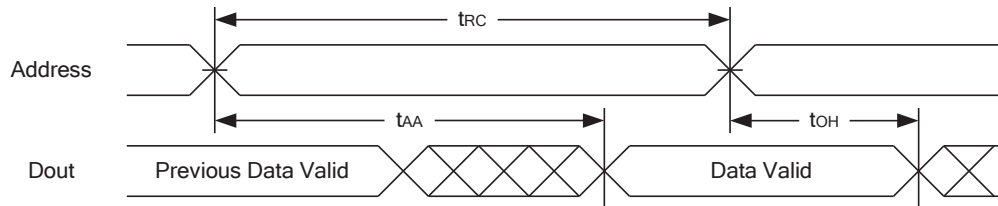
#### (2) WRITE CYCLE

PARAMETER	SYM.	AS6C1608B-45		55ns Specification		UNIT
		MIN.	MAX.	MIN.	MAX.	
Write Cycle Time	t <sub>WC</sub>	45	-	55	-	ns
Address Valid to End of Write	t <sub>AW</sub>	40	-	50	-	ns
Chip Enable to End of Write	t <sub>CW</sub>	40	-	50	-	ns
Address Set-up Time	t <sub>AS</sub>	0	-	0	-	ns
Write Pulse Width	t <sub>WP</sub>	35	-	45	-	ns
Write Recovery Time	t <sub>WR</sub>	0	-	0	-	ns
Data to Write Time Overlap	t <sub>DW</sub>	20	-	25	-	ns
Data Hold from End of Write Time	t <sub>DH</sub>	0	-	0	-	ns
Output Active from End of Write	t <sub>OW</sub> *	5	-	5	-	ns
Write to Output in High-Z	t <sub>WHZ</sub> *	-	15	-	20	ns

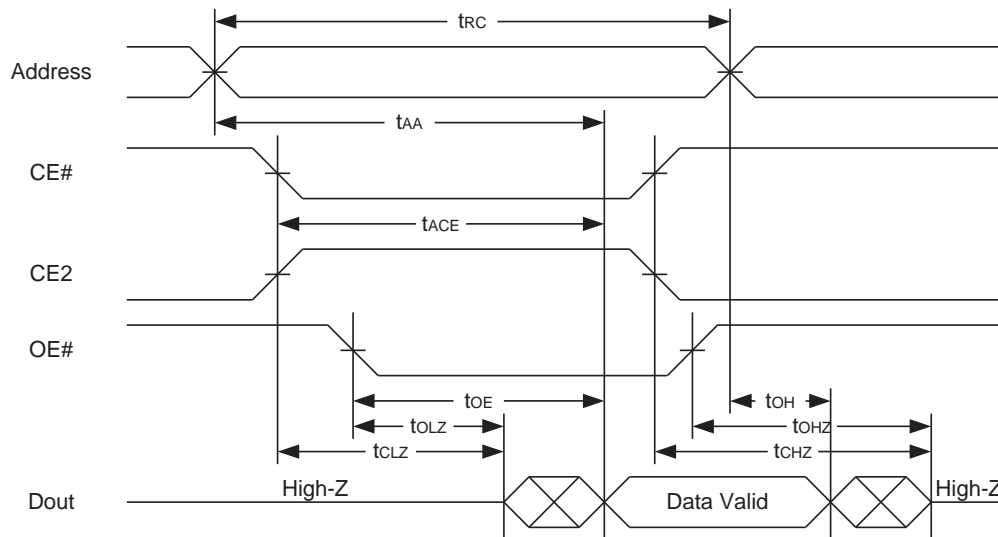
\*These parameters are guaranteed by device characterization, but not production tested.

### TIMING WAVEFORMS

#### READ CYCLE 1 (Address Controlled) (1,2)



#### READ CYCLE 2 (CE# and CE2 and OE# Controlled) (1,3,4,5)

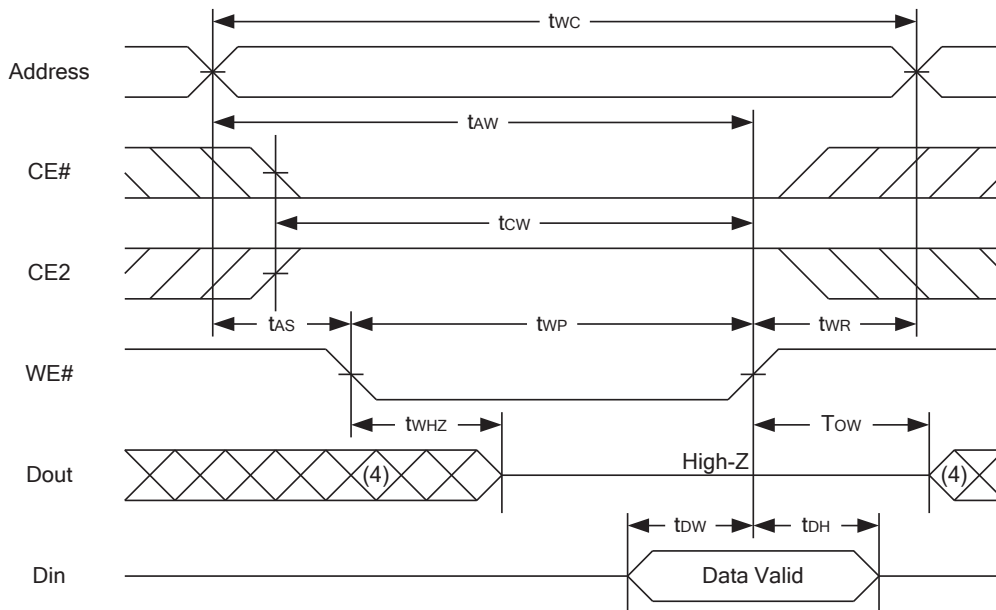


#### Notes :

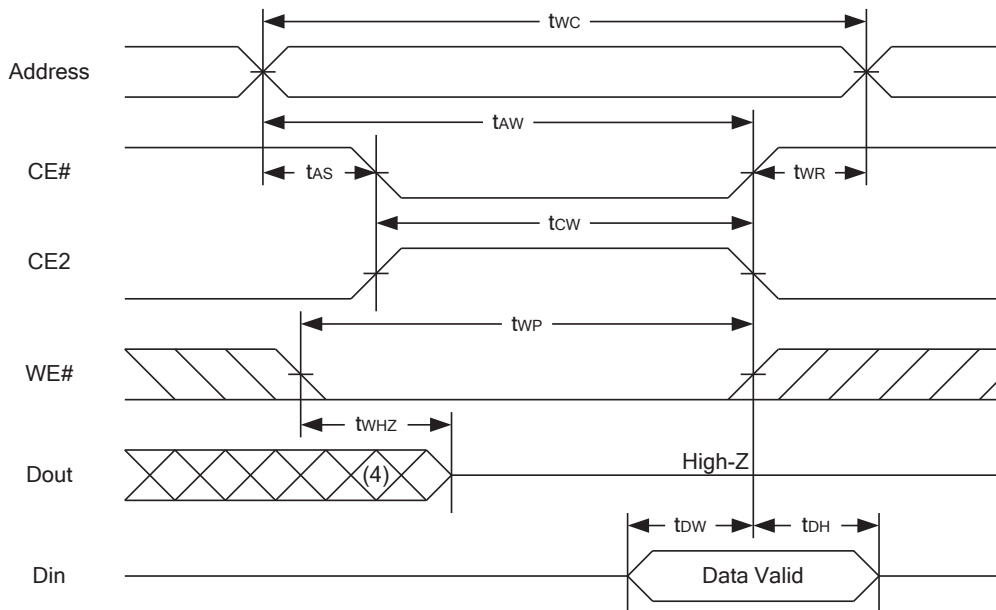
1. WE# is high for read cycle.
2. Device is continuously selected OE# = low, CE# = low., CE2 = high.
3. Address must be valid prior to or coincident with CE# = low, CE2 = high; otherwise tAA is the limiting parameter.
4. tCLZ, tOLZ, tCHZ and tOHZ are specified with CL = 5pF. Transition is measured  $\pm 500\text{mV}$  from steady state.
5. At any given temperature and voltage condition, tCHZ is less than tCLZ, tOHZ is less than tOLZ.

## 16Mb (2048K x 8 Bits) LOW POWER CMOS SRAM

### WRITE CYCLE 1 (WE# Controlled) (1,2,4,5)



### WRITE CYCLE 2 (CE# and CE2 Controlled) (1,4,5)



#### Notes :

1. A write occurs during the overlap of a low CE#, high CE2, low WE#.
2. During a WE# controlled write cycle with OE# low, tWP must be greater than tWHZ + tDW to allow the drivers to turn off and data to be placed on the bus.
3. During this period, I/O pins are in the output state, and input signals must not be applied.
4. If the CE# low transition and CE2 high transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
5. tOW and tWHZ are specified with CL = 5pF. Transition is measured  $\pm 500\text{mV}$  from steady state.



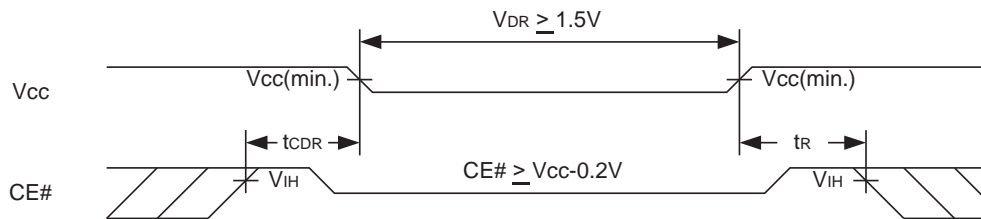
### DATA RETENTION CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
VCC for Data Retention	V <sub>DR</sub>	CE# ≥ V <sub>CC</sub> - 0.2V or CE2 ≤ 0.2V		1.5	-	3.6	V
Data Retention Current	I <sub>DR</sub>	V <sub>CC</sub> = 1.2V CE# ≥ V <sub>CC</sub> -0.2V or CE2 ≤ 0.2V Other pins at 0.2V or V <sub>CC</sub> -0.2V	40°C	-	4	10	μA
			-40C~85°C	-	4	40	μA
Chip Disable to Data Retention Time	t <sub>CDR</sub>	See Data Retention Waveforms (below)		0	-	-	ns
Recovery Time	t <sub>R</sub>			t <sub>RC</sub> *	-	-	ns

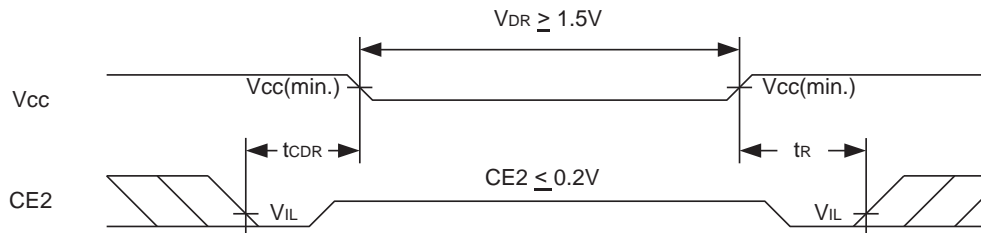
t<sub>RC</sub>\* = Read Cycle Time

### DATA RETENTION WAVEFORM

Low V<sub>CC</sub> Data Retention Waveform (1) (CE# controlled)

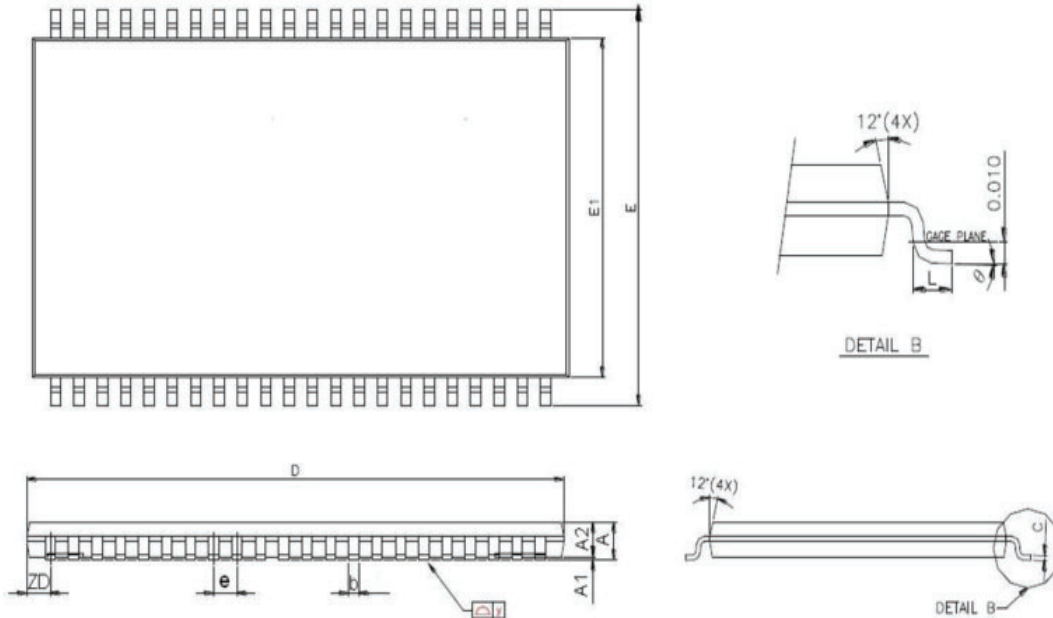


Low V<sub>CC</sub> Data Retention Waveform (2) (CE2 controlled)



### PACKAGE OUTLINE DIMENSION

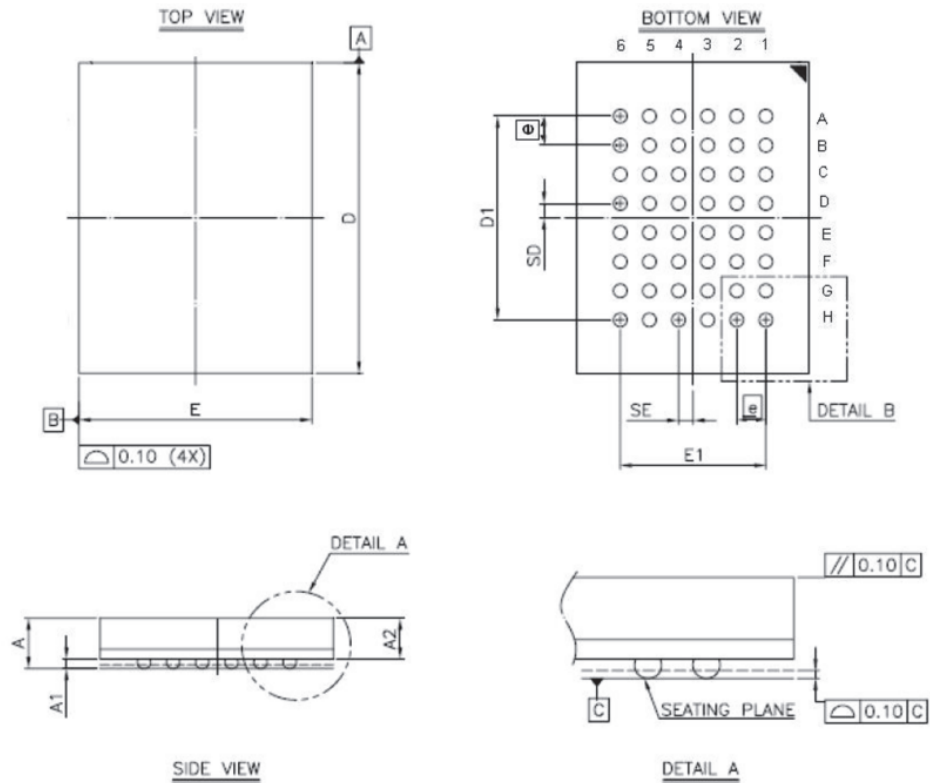
44-pin 400mil TSOP-II Package Outline Dimension



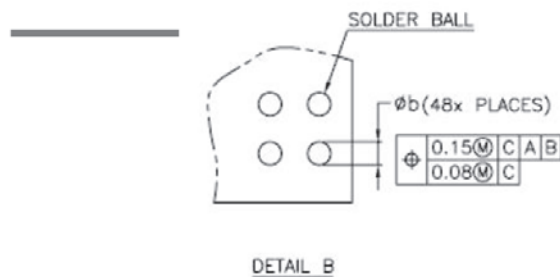
SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN MILS		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	-	-	1.20	-	-	47.2
A1	0.05	0.10	0.15	2.0	3.9	5.9
A2	0.95	1.00	1.05	37.4	39.4	41.3
b	0.30	-	0.45	11.8	-	17.7
c	0.12	-	0.21	4.7	-	8.3
D	18.212	18.415	18.618	717	725	733
E	11.506	11.760	12.014	453	463	473
E1	9.957	10.160	10.363	392	400	408
e	-	0.800	-	-	31.5	-
L	0.40	0.50	0.60	15.7	19.7	23.6
ZD	-	0.805	-	-	31.7	-
y	-	-	0.076	-	-	3
θ	0°	3°	6°	0°	3°	6°

## 16Mb (2048K x 8 Bits) LOW POWER CMOS SRAM

### 48-ball 6mm x 8mm TFBGA Package Outline Dimension



SYM.	DIMENSION (mm)			DIMENSION (inch)		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	—	—	1.40	—	—	0.055
A1	0.20	0.25	0.30	0.008	0.010	0.012
A2	—	—	1.05	—	—	0.041
b	0.30	0.35	0.40	0.012	0.014	0.016
D	7.95	8.00	8.05	0.313	0.315	0.317
D1	5.25 BSC			0.207 BSC		
E	5.95	6.00	6.05	0.234	0.236	0.238
E1	3.75 BSC			0.148 BSC		
SE	0.375 TYP			0.015 TYP		
SD	0.375 TYP			0.015 TYP		
⊕	0.75 BSC			0.030 BSC		



NOTE:  
 1. CONTROLLING DIMENSION : MILLIMETER.  
 2. REFERENCE DOCUMENT : JEDEC MO-207.

### ORDERING INFORMATION

Alliance Part no	Organisation	Vcc Range	Package	Operating Temp	Speed ns
AS6C1608B-45BIN - Tray	2048K x 8	2.7V – 3.6V	48-ball 6mm x 8mm TFBGA	-40°C~85°C	45
AS6C1608B-45BINTR – Tape & Reel	2048K x 8	2.7V – 3.6V	48-ball 6mm x 8mm TFBGA	-40°C~85°C	45
AS6C1608B-45TIN – Tray	2048K x 8	2.7V – 3.6V	44-pin 400mil TSOP-II	-40°C~85°C	45
AS6C1608B-45TINTR – Tape & Reel	2048K x 8	2.7V – 3.6V	44-pin 400mil TSOP-II	-40°C~85°C	45

### PART NUMBERING SYSTEM

AS6C	1608B	- 45	B or T	I	N
LOW POWER SRAM PREFIX	DEVICE NUMBER 16 = 16M 08 = by 8 B = Die rev.B	Access Time 45 = 45ns	B = 48ball TFBGA (6mm x 8mm) Or T = 44-pin 400mil TSOP-II	Temperature range: I = Industrial (-40°C to 85°C)	N = Lead Free ROHS Compliant Part



# AS6C1608B

## 16Mb (2048K x 8 Bits) LOW POWER CMOS SRAM

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Alliance Memory, Inc.  
12815 NE 124th St STE#D Kirkland, WA 98034, USA  
Tel: +1(425)898-4456  
Fax +1(425)896-8628

[www.alliancememory.com](http://www.alliancememory.com)

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